

<b>Notice of References Cited</b>	Application/Control No. 10/728,616	Applicant(s)/Patent Under Reexamination KLOSTER ET AL.	
	Examiner Khiem D Nguyen	Art Unit 2823	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0203668	10-2003	Cobbley et al.	439/323
*	C	US-2002/0109228	08-2002	Buchwalter et al.	257/738
	D	US-			
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	K	US-			
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**NON-PATENT DOCUMENTS**

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